EP2600PD-12.096M



EP26 00

Series -RoHS Compliant (Pb-free) 3.3V 4 Pad 5mm x 7mm Ceramic SMD LVCMOS Programmable Oscillator

Frequency Tolerance/Stability ±100ppm Maximum

ae

PD -12.096M Nominal Frequency

12.096MHz

Pin 1 Connection Power Down (Disable Output: Logic Low)

Duty Cycle 50 ±10(%)

| Oper | aung | rem | perai | ure | пап |
|-------|---------|-----|-------|-----|-----|
| -20°C | C to +7 | O°C | | | |

| ELECTRICAL SPECIFICA | TIONS |
|---------------------------------------|--|
| Nominal Frequency | 12.096MHz |
| Frequency Tolerance/Stability | ±100ppm Maximum (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range,Supply Voltage Change, Output Load Change, First Year Aging at 25°C, Shock, and Vibration) |
| Aging at 25°C | ±5ppm/year Maximum |
| Operating Temperature Range | -20°C to +70°C |
| Supply Voltage | 3.3Vdc ±0.3Vdc |
| Input Current | 28mA Maximum (Unloaded) |
| Output Voltage Logic High (Voh) | Vdd-0.4Vdc Minimum (IOH= -8mA) |
| Output Voltage Logic Low (Vol) | 0.4Vdc Maximum (IOL= +8mA) |
| Rise/Fall Time | 4nSec Maximum (Measured at 20% to 80% of waveform) |
| Duty Cycle | 50 ±10(%) (Measured at 50% of waveform) |
| Load Drive Capability | 30pF Maximum |
| Output Logic Type | CMOS |
| Pin 1 Connection | Power Down (Disable Output: Logic Low) |
| Tri-State Input Voltage (Vih and Vil) | 70% of Vdd Minimum to enable output, 20% of Vdd Maximum to disable output, No Connect to enable output. |
| Standby Current | 20µA Maximum (Pin 1 = Ground) |
| Disable Current | 16mA Maximum (Pin 1 = Ground) |
| Absolute Clock Jitter | ±250pSec Maximum, ±100pSec Typical |
| One Sigma Clock Period Jitter | ±50pSec Maximum |
| Start Up Time | 10mSec Maximum |

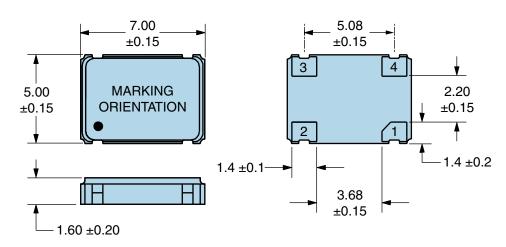
Storage Temperature Range -55°C to +125°C

ENVIRONMENTAL & MECHANICAL SPECIFICATIONS

| ESD Susceptibility | MIL-STD-883, Method 3015, Class 1, HBM: 1500V |
|------------------------------|---|
| Fine Leak Test | MIL-STD-883, Method 1014, Condition A |
| Flammability | UL94-V0 |
| Gross Leak Test | MIL-STD-883, Method 1014, Condition C |
| Mechanical Shock | MIL-STD-883, Method 2002, Condition B |
| Moisture Resistance | MIL-STD-883, Method 1004 |
| Moisture Sensitivity | J-STD-020, MSL 1 |
| Resistance to Soldering Heat | MIL-STD-202, Method 210, Condition K |
| Resistance to Solvents | MIL-STD-202, Method 215 |
| Solderability | MIL-STD-883, Method 2003 |
| Temperature Cycling | MIL-STD-883, Method 1010, Condition B |
| Vibration | MIL-STD-883, Method 2007, Condition A |

EP2600PD-12.096M

MECHANICAL DIMENSIONS (all dimensions in millimeters)

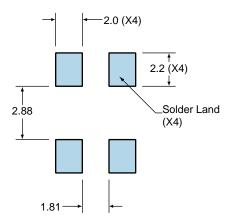


| 1 | E | CL | IP1 | EK® |
|---|---|-----|------------|------|
| | C | ORP | ORA | TION |

| PIN | CONNECTION |
|-------------|------------------------|
| 1 | Power Down (Logic Low) |
| 2 3 | Ground/Case Ground |
| 3 | Output |
| 4 | Supply Voltage |
| LINE | MARKING |
| | |
| 1 | ECLIPTEK |
| 1 2 3 | ECLIPTEK 12.096M |

Suggested Solder Pad Layout

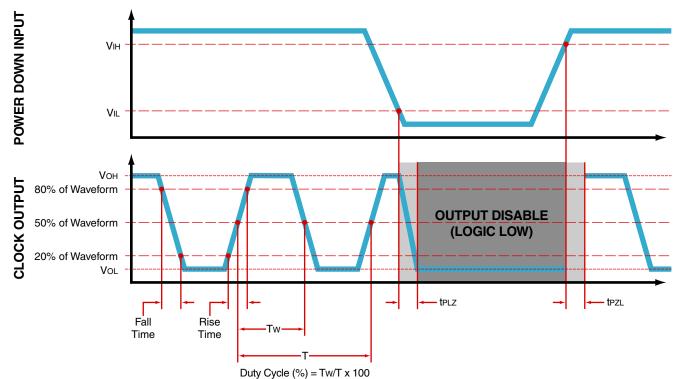
All Dimensions in Millimeters



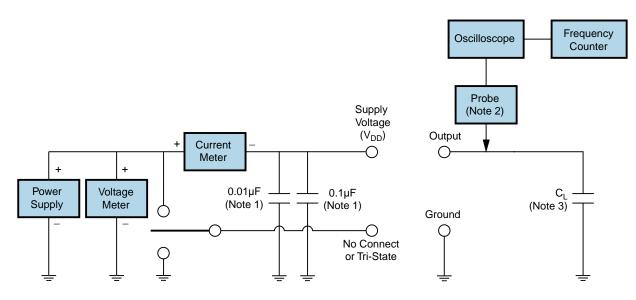
All Tolerances are ±0.1

EP2600PD-12.096M









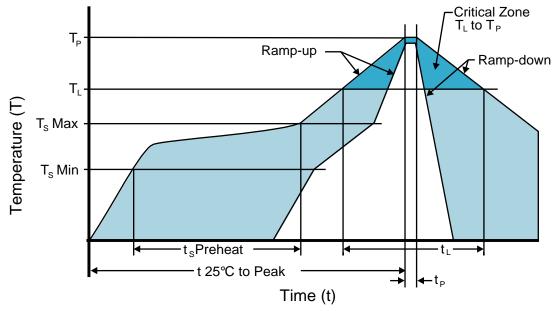
Note 1: An external 0.1μ F low frequency tantalum bypass capacitor in parallel with a 0.01μ F high frequency ceramic bypass capacitor close to the package ground and V_{DD} pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value \dot{C}_L includes sum of all probe and fixture capacitance.



Recommended Solder Reflow Methods



High Temperature Infrared/Convection

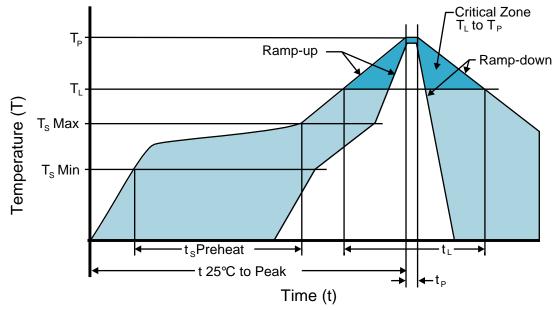
EP2600PD-12.096M

| T _s MAX to T _L (Ramp-up Rate) | 3°C/second Maximum |
|---|---|
| Preheat | |
| - Temperature Minimum (T _s MIN) | 150°C |
| - Temperature Typical (T _s TYP) | 175°C |
| Temperature Maximum (T_s MAX) | 200°C |
| - Time (t _s MIN) | 60 - 180 Seconds |
| Ramp-up Rate (T _L to T _P) | 3°C/second Maximum |
| Time Maintained Above: | |
| - Temperature (T∟) | 217°C |
| - Time (t∟) | 60 - 150 Seconds |
| Peak Temperature (T _P) | 260°C Maximum for 10 Seconds Maximum |
| Target Peak Temperature (T _P Target) | 250°C +0/-5°C |
| Time within 5°C of actual peak (t _p) | 20 - 40 seconds |
| Ramp-down Rate | 6°C/second Maximum |
| Time 25°C to Peak Temperature (t) | 8 minutes Maximum |
| Moisture Sensitivity Level | Level 1 |
| Additional Notes | Temperatures shown are applied to body of device. |
| | |



Recommended Solder Reflow Methods

EP2600PD-12.096M



Low Temperature Infrared/Convection 240°C

| T_s MAX to T_L (Ramp-up Rate) | 5°C/second Maximum |
|--|--|
| Preheat | |
| - Temperature Minimum (T _s MIN) | N/A |
| - Temperature Typical (T _s TYP) | 150°C |
| - Temperature Maximum (T _s MAX) | N/A |
| - Time (t _s MIN) | 60 - 120 Seconds |
| Ramp-up Rate (T⊾ to T _P) | 5°C/second Maximum |
| Time Maintained Above: | |
| - Temperature (T∟) | 150°C |
| - Time (t∟) | 200 Seconds Maximum |
| Peak Temperature (T _P) | 240°C Maximum |
| Target Peak Temperature (T _P Target) | 240°C Maximum 1 Time / 230°C Maximum 2 Times |
| Time within 5°C of actual peak (t _p) | 10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time |
| Ramp-down Rate | 5°C/second Maximum |
| Time 25°C to Peak Temperature (t) | N/A |
| Moisture Sensitivity Level | Level 1 |
| Additional Notes | Temperatures shown are applied to body of device. |

Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)

High Temperature Manual Soldering

260°C Maximum for 5 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)